8-bit serial/parallel register with sign extend (3-State)   74F322
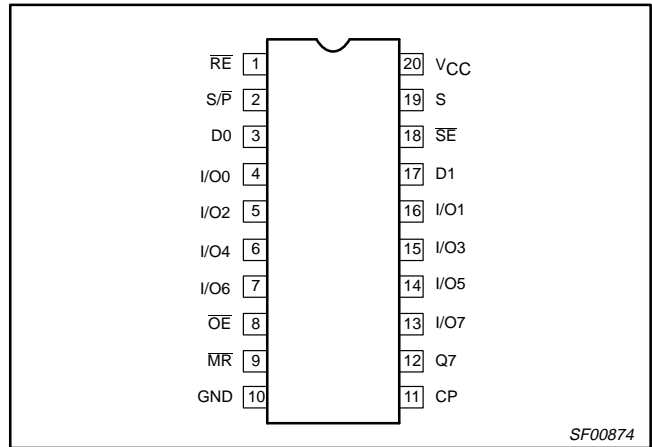
FEATURES

- Multiplexed parallel I/O ports
- Separate serial input and output
- Sign extend function
- 3-State outputs for bus applications
- Direct Overriding Clear

DESCRIPTION

The 74F322 is an 8-bit shift register with provision for either serial or parallel loading and with 3-State parallel outputs plus a bi-state serial output. Parallel data inputs and outputs are multiplexed to minimize pin count. State changes are initiated by the rising edge of the clock. Four synchronous modes of operation are possible: hold (store), shift right with serial entry, shift right with sign extend, and parallel load. An asynchronous Master Reset ($\overline{MR}$) input overrides clocked operation and clears the registers.

The 74F322 contains eight D-type edge triggered flip-flops and the interstage gating required to perform right shift and the intrastage gating necessary for hold and synchronous parallel load operations. A Low signal on $\overline{RE}$ enables shifting or parallel loading, while a High signal enables the hold mode. A High signal on S/$\overline{P}$ enables shift right, while a Low signal disables the 3-State output buffers and enables parallel loading. In the shift right mode a High signal on $\overline{SE}$ enables serial entry from either D0 or D1, as determined by the S input. A Low signal on $\overline{SE}$ enables shift right, but Q7 reloads its contents, thus performing the sign extend function. A High signal on $\overline{OE}$ disables the 3-State output buffers, regardless of the other control inputs. In this condition the shifting and loading operations can still be performed.

PIN CONFIGURATION

$\overline{RE}$	1		20	V_{CC}
S/$\overline{P}$	2		19	S
D0	3		18	$\overline{SE}$
I/O0	4		17	D1
I/O2	5		16	I/O1
I/O4	6		15	I/O3
I/O6	7		14	I/O5
$\overline{OE}$	8		13	I/O7
$\overline{MR}$	9		12	Q7
GND	10		11	CP

SF00874

TYPE	TYPICAL f_{MAX}	TYPICAL SUPPLY CURRENT (TOTAL)
74F322	125MHz	60mA

ORDERING INFORMATION

| DESCRIPTION	ORDER CODE
	COMMERCIAL RANGE $V_{CC} = 5V \pm 10\%$, $T_{amb} = 0°C$ to $+70°C$
20-pin plastic DIP	N74F322N
20-pin plastic SOL	N74F322D

INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

PINS	DESCRIPTION	74F(U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
D0, D1	Serial data inputs	1.0/1.0	20µA/0.6mA
S	Serial data select input	1.0/2.0	20µA/1.2mA
$\overline{SE}$	Sign Extend input	1.0/3.0	20µA/1.8mA
CP	Clock Pulse input (Active rising edge)	1.0/1.0	20µA/0.6mA
S/$\overline{P}$	Serial (High) or Parallel (Low) mode control input	1.0/1.0	20µA/0.6mA
$\overline{RE}$	Register Enable input (Active Low)	1.0/1.0	20µA/0.6mA
$\overline{MR}$	Asynchronous Master Reset input (Active Low)	1.0/1.0	20µA/0.6mA
$\overline{OE}$	Output Enable input (Active Low)	1.0/1.0	20µA/0.6mA
Q7	Bi-state serial output	50/33	1.0mA/20mA
I/On	Multiplexed parallel data inputs or	3.5/1.0	70µA/0.6mA
	3-State parallel outputs	150/40	3.0mA/24mA

NOTE: One (1.0) FAST Unit Load (U.L.) is defined as: 20µA in the High State and 0.6mA in the Low state.
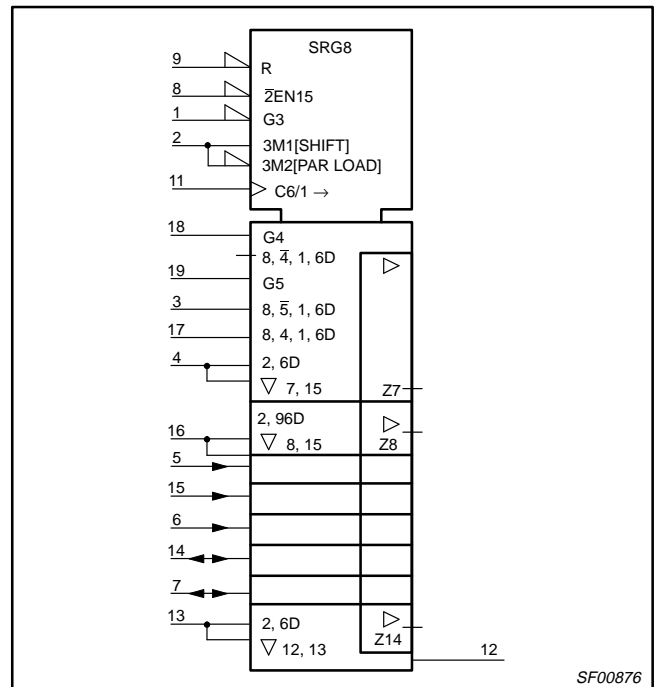
8-bit serial/parallel register with sign extend (3-State)

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LOGIC SYMBOL

SF00875
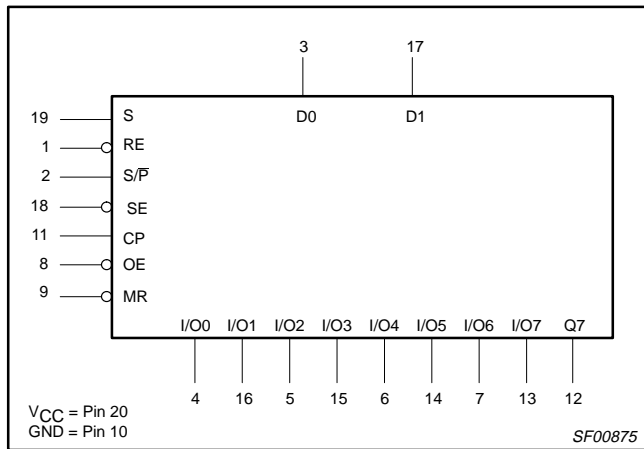
LOGIC SYMBOL (IEEE/IEC)

SF00876

FUNCTION TABLE

INPUTS							INPUTS									OPERATING MODE
$\overline{MR}$	$\overline{RE}$	S/$\overline{P}$	$\overline{SE}$	S	$\overline{OE}$*	CP	I/O0	I/O1	I/O2	I/O3	I/O4	I/O5	I/O6	I/O7	Q7	
L	H	X	X	X	L	X	L	L	L	L	L	L	L	L	L	Clear
L	X	H	X	X	L	X	L	L	L	L	L	L	L	L	L	
H	L	L	X	X	X	↑	I0	I1	I2	I3	I4	I5	I6	I7	I7	Parallel load
H	L	H	H	L	L	↑	D0	O0	O1	O2	O3	O4	O5	O6	O6	Shift right
H	L	H	H	H	L	↑	D1	O0	O1	O2	O3	O4	O5	O6	O6	
H	L	H	L	X	L	↑	O0	O0	O1	O2	O3	O4	O5	O6	O6	Sign extend
H	H	X	X	X	L	X	NC	NC	NC	NC	NC	NC	NC	NC	NC	Hold
X	L	L	X	X	X	X	Z	Z	Z	Z	Z	Z	Z	Z	NC	3-State
X	X	X	X	X	H	⤒	Z	Z	Z	Z	Z	Z	Z	Z	NC	

* = When the input is High, all I/O terminals are at the high impedance state, sequential operation or clearing of the register is not affected.

H = High voltage level
L = Low voltage level
NC = No change
X = Don't care
Z = High impedance "off" state
↑ = Low-to-High clock transition
I0–I7 = The level of the steady state input at the respective I/O terminal is loaded into the flip-flop while the flip-flop outputs (except Q7) are isolated from the I/O terminal.
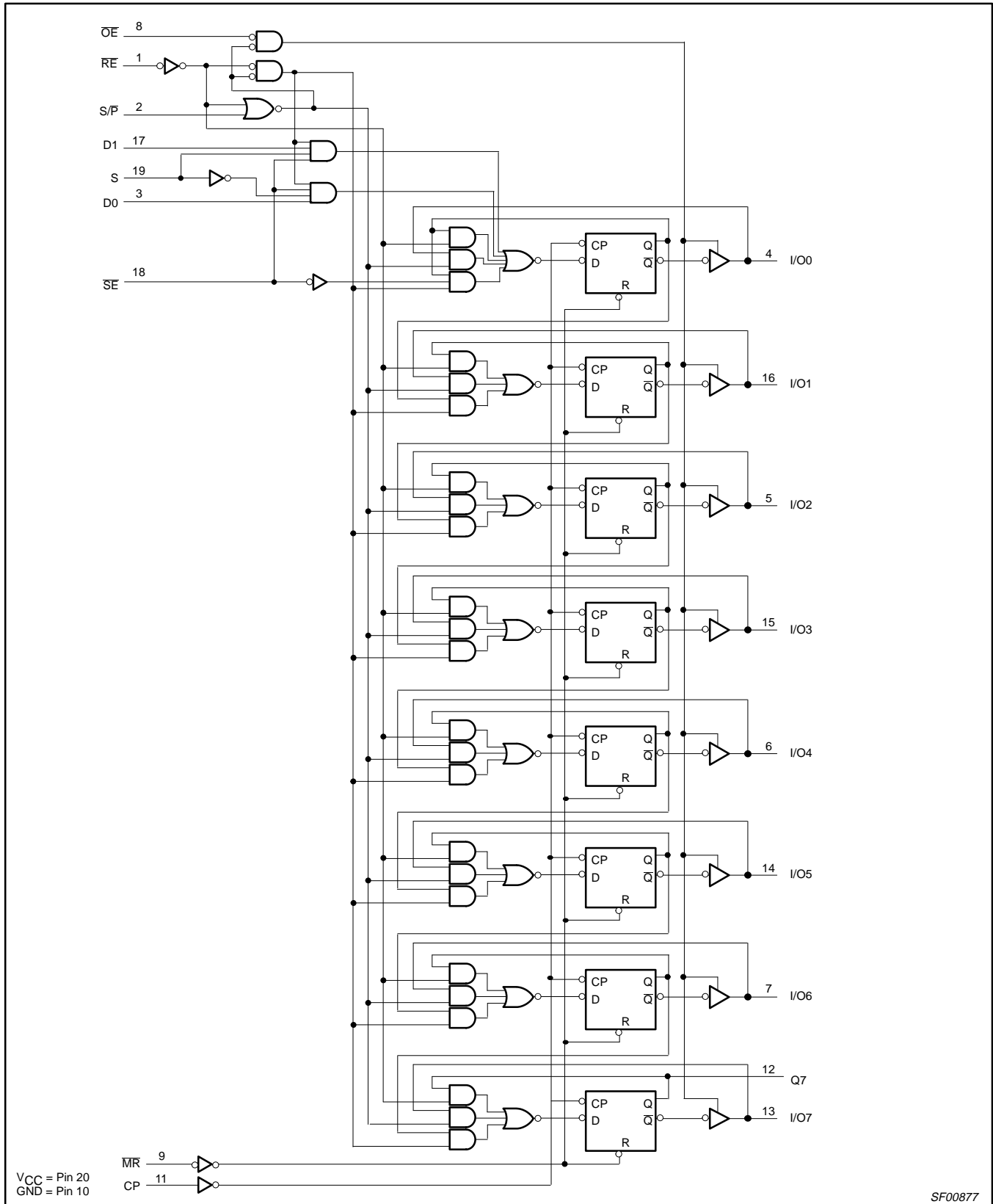D0–D7 = The level of the steady state inputs to the serial multiplexer input.
O0–O7 = The level of the respective Qn flip-flop prior to the last clock Low-to-High transition.
⤒ = Not a Low-to-High clock transition.

8-bit serial/parallel register with sign extend (3-State)

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LOGIC DIAGRAM

SF00877

8-bit serial/parallel register with sign extend (3-State)

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ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limits set forth in this table may impair the useful life of the device. Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER		RATING	UNIT
V_{CC}	Supply voltage		−0.5 to +7.0	V
V_{IN}	Input voltage		−0.5 to +7.0	V
I_{IN}	Input current		−30 to +5	mA
V_{OUT}	Voltage applied to output in High output state		−0.5 to +5.5	V
I_{OUT}	Current applied to output in Low output state	Q7	40	mA
		I/On	48	mA
T_{amb}	Operating free-air temperature range		0 to +70	°C
T_{stg}	Storage temperature		−65 to +150	°C

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER		LIMITS			UNIT
			MIN	NOM	MAX	
V_{CC}	Supply voltage		4.5	5.0	5.5	V
V_{IH}	High-level input voltage		2.0			V
V_{IL}	Low-level input voltage				0.8	V
I_{IK}	Input clamp current				−18	mA
I_{OH}	High-level output current	Q7			−1	mA
		I/On			−3	mA
I_{OL}	Low-level output current	Q7			20	mA
		I/On			24	mA
T_{amb}	Operating free-air temperature range		0		70	°C

8-bit serial/parallel register with sign extend (3-State)

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DC ELECTRICAL CHARACTERISTICS
(Over recommended operating free-air temperature range unless otherwise noted.)

SYMBOL	PARAMETER		TEST CONDITIONS[1]			LIMITS			UNIT
						MIN	TYP[2]	MAX	
V_{OH}	High-level output voltage	Q7	V_{CC} = MIN, V_{IL} = MAX, V_{IH} = MIN	I_{OH} = −1mA	±10%V_{CC}	2.5			V
					±5%V_{CC}	2.7	3.4		V
		I/On		I_{OH} = −3mA	±10%V_{CC}	2.4			V
					±5%V_{CC}	2.7	3.3		V
V_{OL}	Low-level output voltage		V_{CC} = MIN, V_{IL} = MAX, V_{IH} = MIN	I_{OL} = MAX	±10%V_{CC}		0.38	0.55	V
					±5%V_{CC}		0.35	0.50	V
V_{IK}	Input clamp voltage		V_{CC} = MIN, I_I = I_{IK}				−0.73	−1.2	V
I_I	Input current at maximum input voltage	others	V_{CC} = MAX, V_I = 7.0V					100	µA
		I/On	V_{CC} = MAX, V_I = 5.5V					1	mA
I_{IH}	High-level input current		V_{CC} = MAX, V_I = 2.7V					20	µA
I_{IL}	Low-level input current	$\overline{SE}$	V_{CC} = MAX, V_I = 0.5V					−1.8	mA
		S						−1.2	mA
		others						−0.6	mA
I_{IH} + I_{OZH}	Off-state output current High-level voltage applied		V_{CC} = MAX, V_I = 2.7V					70	µA
I_{IL} + I_{OZL}	Off-state output current Low-level voltage applied		V_{CC} = MAX, V_I = 0.5V					−0.6	mA
I_{OS}	Short-circuit output current[3]		V_{CC} = MAX			−60		−150	mA
I_{CC}	Supply current (total)	I_{CCH}	V_{CC} = MAX				50	75	mA
		I_{CCL}					60	90	mA
		I_{CCZ}					65	95	mA

NOTES:
1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.
2. All typical values are at V_{CC} = 5V, T_{amb} = 25°C.
3. Not more than one output should be shorted at a time. For testing I_{OS}, the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I_{OS} tests should be performed last.

8-bit serial/parallel register with sign extend (3-State)

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AC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS					UNIT
			$T_{amb} = +25°C$ $V_{CC} = +5.0V$ $C_L = 50pF, R_L = 500\Omega$			$T_{amb} = 0°C$ to $+70°C$ $V_{CC} = +5.0V \pm 10\%$ $C_L = 50pF, R_L = 500\Omega$		
			MIN	TYP	MAX	MIN	MAX	
f_{MAX}	Maximum clock frequency	Waveform 1	110	125		90		MHz
t_{PLH} t_{PHL}	Propagation delay CP to I/On	Waveform 1	4.0 4.5	6.0 7.0	9.0 9.5	4.0 4.5	10.0 10.0	ns ns
t_{PLH} t_{PHL}	Propagation delay CP to Q7	Waveform 1	4.5 5.0	6.5 6.5	9.0 9.0	4.5 5.0	10.0 9.0	ns ns
t_{PHL}	Propagation delay $\overline{MR}$ to I/On	Waveform 2	5.0	6.5	9.5	4.5	10.0	ns
t_{PHL}	Propagation delay $\overline{MR}$ to Q7	Waveform 2	5.0	6.5	9.5	4.5	10.0	ns
t_{PZH} t_{PZL}	Output Enable time $\overline{OE}$ to I/On	Waveform 4 Waveform 5	3.0 5.5	5.0 7.5	8.0 10.5	3.0 5.0	9.0 11.0	ns ns
t_{PHZ} t_{PLZ}	Output Disable time $\overline{OE}$ to I/On	Waveform 4 Waveform 5	2.0 1.0	4.0 2.5	6.5 5.5	2.0 1.0	7.5 6.0	ns ns
t_{PZH} t_{PZL}	Output Disable time $S/\overline{P}$ to I/On	Waveform 4 Waveform 5	4.0 6.0	6.0 8.0	9.0 11.0	3.5 5.5	10.0 11.5	ns ns
t_{PHZ} t_{PLZ}	Output Disable time $S/\overline{P}$ to I/On	Waveform 4 Waveform 5	4.0 2.0	6.0 4.0	9.0 7.0	3.5 2.0	10.5 7.5	ns ns
t_{PZH} t_{PZL}	Output Disable time $\overline{RE}$ to I/On	Waveform 4 Waveform 5	8.0 9.0	9.5 11.0	12.5 14.0	7.0 8.0	14.0 16.0	ns ns
t_{PHZ} t_{PLZ}	Output Disable time $\overline{RE}$ to I/On	Waveform 4 Waveform 5	6.5 4.5	8.5 6.5	11.5 9.5	5.5 4.0	13.0 10.5	ns ns

8-bit serial/parallel register with sign extend (3-State) 74F322

AC SETUP REQUIREMENTS

| SYMBOL	PARAMETER	TEST CONDITIONS	T_{amb} = +25°C V_{CC} = +5.0V C_L = 50pF, R_L = 500Ω			T_{amb} = 0°C to +70°C V_{CC} = +5.0V ± 10% C_L = 50pF, R_L = 500Ω		UNIT
			MIN	TYP	MAX	MIN	MAX	
t_s(H) t_s(L)	Setup time, High or Low $\overline{RE}$ to CP	Waveform 3	8.0 12.5			9.5 14.0		ns ns
t_h(H) t_h(L)	Hold time, High or Low $\overline{RE}$ to CP	Waveform 3	0 0			0 0		ns ns
t_s(H) t_s(L)	Setup time, High or Low D0, D1 or I/On to CP	Waveform 3	4.0 4.5			6.0 5.0		ns ns
t_h(H) t_h(L)	Hold time, High or Low D0, D1 or I/On to CP	Waveform 3	0 0			0 0		ns ns
t_s(H) t_s(L)	Setup time, High or Low $\overline{SE}$ to CP	Waveform 3	5.5 5.0			7.0 5.5		ns ns
t_h(H) t_h(L)	Hold time, High or Low $\overline{SE}$ to CP	Waveform 3	0 0			0 0		ns ns
t_s(H) t_s(L)	Setup time, High or Low S/$\overline{P}$ to CP	Waveform 3	10.5 9.5			11.0 10.5		ns ns
t_s(H) t_s(L)	Setup time, High or Low S to CP	Waveform 3	4.0 8.5			4.5 9.5		ns ns
t_h(H) t_h(L)	Hold time, High or Low S or S/$\overline{P}$ to CP	Waveform 3	0 0			0 0		ns ns
t_w(H) t_w(L)	CP Pulse width, High or Low	Waveform 3	5.0 5.0			5.0 5.0		ns
t_w(L)	$\overline{MR}$ Pulse width, Low	Waveform 3	5.0			5.0		ns
t_{REC}	Recovery time, $\overline{MR}$ to CP	Waveform 2	4.0			4.5		ns

8-bit serial/parallel register with sign extend (3-State)
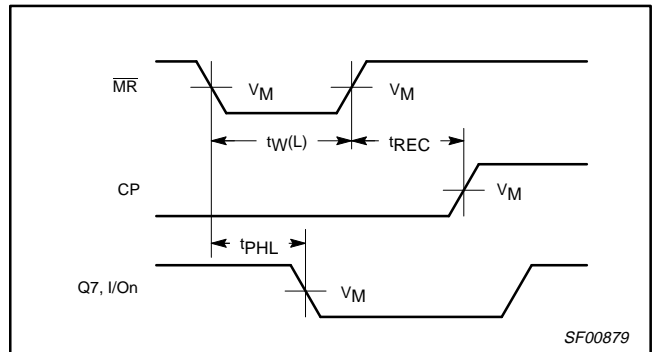
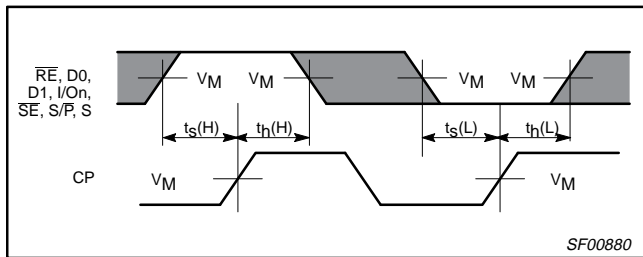## 74F322

AC WAVEFORMS

For all waveforms, $V_M = 1.5V$
The shaded areas indicate when the input is permitted to change for predictable output performance.
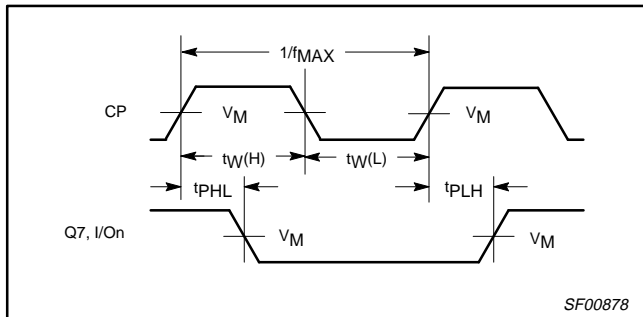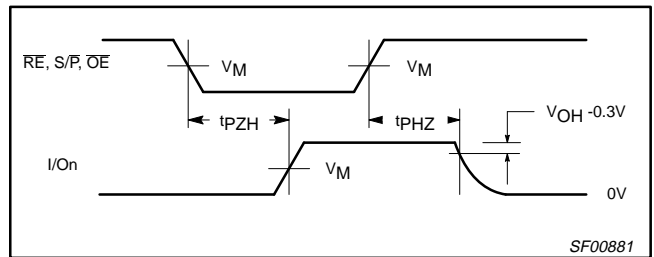

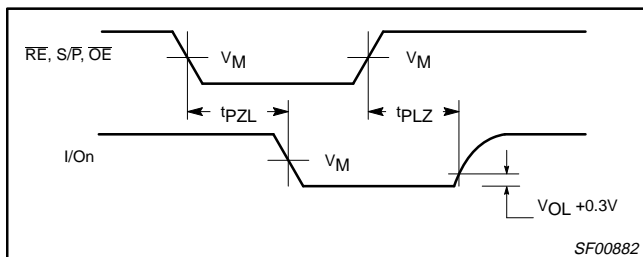**Waveform 1. Propagation Delay, Clock Input to Output, Clock Pulse Width, and Maximum Clock Frequency**

Waveform 2. Master Reset Pulse Width, Master Reset to Output Delay, and Master Reset to Clock Recovery Time

Waveform 3. Data Setup and Hold Times

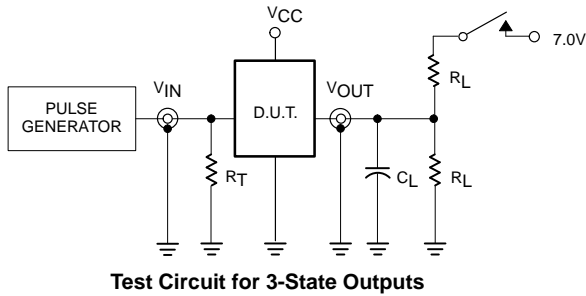**Waveform 4. 3-State Output Enable Time to High Level and Output Disable Time from High Level**

Waveform 5. 3-State Output Enable Time to Low Level and Output Disable Time from Low Level

8-bit serial/parallel register with sign extend (3-State)

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TEST CIRCUIT AND WAVEFORM

Test Circuit for 3-State Outputs

Input Pulse Definition

SWITCH POSITION

TEST	SWITCH
t_{PLZ}	closed
t_{PZL}	closed
All other	open

DEFINITIONS:

R_L = Load resistor;
    see AC electrical characteristics for value.

C_L = Load capacitance includes jig and probe capacitance;
    see AC electrical characteristics for value.

R_T = Termination resistance should be equal to Z_{OUT} of
    pulse generators.
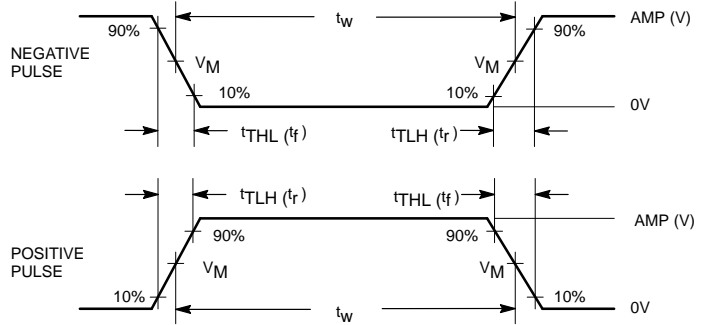
family	INPUT PULSE REQUIREMENTS					
	amplitude	V_M	rep. rate	t_w	t_{TLH}	t_{THL}
74F	3.0V	1.5V	1MHz	500ns	2.5ns	2.5ns

SF00777